

DEPARTMENT OF COMMERCE**National Institute of Standards and Technology****Proposed Information Collection; Comment Request; Hollings Manufacturing Extension Partnership (HMEP) Program Application Requirements**

AGENCY: National Institute of Standards and Technology (NIST), Commerce.

ACTION: Notice.

SUMMARY: The Department of Commerce, as part of its continuing effort to reduce paperwork and respondent burden, invites the general public and other Federal agencies to take this opportunity to comment on proposed and/or continuing information collections, as required by the Paperwork Reduction Act of 1995.

DATES: Written comments must be submitted on or before October 16, 2009.

ADDRESSES: Direct all written comments to Diana Hynek, Departmental Paperwork Clearance Officer, Department of Commerce, Room 7845, 14th and Constitution Avenue, NW., Washington, DC 20230 (or via the Internet at dHynek@doc.gov).

FOR FURTHER INFORMATION CONTACT: Requests for additional information or copies of the information collection instrument and instructions should be directed to Diane Henderson at (301) 975-5105 or by e-mail at Diane.Henderson@nist.gov.

SUPPLEMENTARY INFORMATION:**I. Abstract**

The objective of NIST Hollings Manufacturing Extension Partnership Program (HMEP) is to enhance productivity, technological performance, and strengthen the global competitiveness of small- and medium-sized U.S.-based manufacturing firms. Rather than creating products, services, and programs from scratch, HMEP works with partners to leverage resources and bring those resources to manufacturing clients. The nationwide network, with its direct reach to the nation's manufacturers, has proven to be invaluable to numerous Federal government partners who utilize the network to distribute valuable, cutting-edge information and resources.

This request is for the information collection requirements associated with submission of grant proposals for NIST HMEP funding. The intent of the collection is to meet statutory requirements for NIST HMEP, as well as

compliance with 15 U.S.C. 278k, as implemented in 15 CFR part 290.

The manufacturing extension centers (MECs) are part of the HMEP national system of extension service providers. Currently, the HMEP national system consists of over 400 centers and field offices located throughout the United States and Puerto Rico. The information regarding HMEP and the MECs is provided in the information packet that can be obtained as explained above or on-line at <http://www.mep.nist.gov>.

The focus of a center is to provide those manufacturing extension services required by the small- and medium-sized manufacturers in its service region utilizing the most cost-effective, local, leveraged resources for those services. It is not the intent of this program that the centers perform research and development.

II. Method of Collection

Paper or electronically via <http://www.grants.gov>.

III. Data

OMB Control Number: None.

Form Number: None.

Type of Review: Regular submission.

Affected Public: Not-for-profit institutions or organizations, including universities, State and local governments, and consortia of not-for-profit institutions.

Estimated Number of Respondents: 12.

Estimated Time per Response: 112 hours.

Estimated Total Annual Burden Hours: 448.

Estimated Total Annual Cost to Public: \$100.

IV. Request for Comments

Comments are invited on: (a) Whether the proposed collection of information is necessary for the proper performance of the functions of the agency, including whether the information shall have practical utility; (b) the accuracy of the agency's estimate of the burden (including hours and cost) of the proposed collection of information; (c) ways to enhance the quality, utility, and clarity of the information to be collected; and (d) ways to minimize the burden of the collection of information on respondents, including through the use of automated collection techniques or other forms of information technology.

Comments submitted in response to this notice will be summarized and/or included in the request for OMB approval of this information collection; they also will become a matter of public record.

Dated: August 11, 2009.

Gwellnar Banks,

Management Analyst, Office of the Chief Information Officer.

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DEPARTMENT OF COMMERCE**National Institute of Standards and Technology****Proposed Information Collection; Comment Request; National Voluntary Laboratory Accreditation Program (NVLAP) Information Collection System**

AGENCY: National Institute of Standards and Technology (NIST).

ACTION: Notice.

SUMMARY: The Department of Commerce, as part of its continuing effort to reduce paperwork and respondent burden, invites the general public and other Federal agencies to take this opportunity to comment on proposed and/or continuing information collections, as required by the Paperwork Reduction Act of 1995.

DATES: Written comments must be submitted on or before October 16, 2009.

ADDRESSES: Direct all written comments to Diana Hynek, Departmental Paperwork Clearance Officer, Department of Commerce, Room 6625, 14th and Constitution Avenue, NW., Washington, DC 20230 (or via the Internet at dHynek@doc.gov).

FOR FURTHER INFORMATION CONTACT: Requests for additional information or copies of the information collection instrument and instructions should be directed to the attention of Vanda R. White, National Voluntary Laboratory Accreditation Program, National Institute of Standards and Technology, 100 Bureau Drive, Stop 2140, Gaithersburg, MD 20899-2140; phone: (301) 975-3592; e-mail: vanda.white@nist.gov.

SUPPLEMENTARY INFORMATION:**I. Abstract**

This information is collected from all testing or calibration laboratories that apply for NVLAP accreditation. The applicants provide the minimum information necessary for NVLAP to evaluate the competency of laboratories to carry out specific tests or calibrations or types of tests or calibrations. The applicant provides such information as name, address, phone and fax numbers, and contact person, and selects the test